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Magnetic field-orientation independence of large basal-plane critical currents in RBCO films with correlated pinning nanostructure<sup>1</sup> DAVID CHRISTEN, Y.L. ZUEV, Oak Ridge National Laboratory, S.H. WEE, University of Tennessee, A. GOYAL, C. CANTONI, Oak Ridge National Laboratory, C. TARANTINI, A. GUREVICH, D. LARBALESTIER, Florida State University — It has been widely confirmed that self-assembled columnar stacks of second-phase precipitates aligned near to the c-axis provide strong flux pinning in RBCO epitaxial films. Such growth-controlled nanostructures can be produced by at least two different deposition techniques and for several species of oxide precipitates. For many of these systems, the usual dependence of in-plane critical current densities,  $J_c$ , on field-orientation nearly vanishes at a specific temperature-dependent field,  $B^*(T)$ . The phenomenon can be described by a competition between intrinsic electronic anisotropy and orientation-dependent pinning. A simple model parameterizes the effect through the dependencies  $H_{irr}(\theta)$  and the power-law decay exponent  $\alpha(\theta)$ ,  $\propto H^{-\alpha}$  in the intermediate field regime. Limits to and fundamental where  $J_c$ aspects of the model with respect to these parameters will be discussed.

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